



SEARCHED

Class	Sub.	Date	Exmr.
210	656	2/24/63	ECF

INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

SEARCH - A	Date	Exmr.
copy of the search has been securely attached to the file The logic is as follows L1 plating adj liquid L2 plating adj liquid with chromatography L3 plating adj liquid same chromatography L4 (plating adj liquid) same chromatography L5 (plating adj liquid) same quantity L6 (plating adj liquid) same quality L7 (electroplating adj liquid) same quantity L8 (electroplating adj liquid) with chromatography L9 (electroplating adj solution) with chromatography L10 (removal near ion) with quantity L11 ion L12 (removal near ion) with quality L13 interference L14 210/656-659 CCLs L15 13 and 14 L16 ion near interference L17 14 and 16 L18 ion L19 "4326940, pm. L20 18 and 19 L21 plating adj liquid 6/09/63 L1 evaporative adj light adj scattering adj detector L3 ion L4 210/656 CCLs L5 ion L6 ultra violet same (differential adj refractive) L7 (evaporative adj light adj scattering adj detector) same (differential adj refractive) L8 (evaporative adj light adj scattering adj detector) L9 evaporative adj mass adj detector L10 2 and 11 L11 chromatography L12 1 and 11 L13 evaporative adj light adj scattering adj detector	2/24/63	ECF

(RIGHT OUTSIDE) L11 chromatography
L12 1 and 11
L13 evaporative adj light
adj scattering adj detector